

**Search Notes**

Application/Control No.

10/694,450

Examiner

Minh Nguyen

Applicant(s)/Patent under  
Reexamination

ZHANG, BENYONG

Art Unit

2816

**SEARCHED**

| Class | Subclass | Date | Examiner |
|-------|----------|------|----------|
|       |          |      |          |
|       |          |      |          |
|       |          |      |          |
|       |          |      |          |
|       |          |      |          |
|       |          |      |          |
|       |          |      |          |
|       |          |      |          |
|       |          |      |          |
|       |          |      |          |
|       |          |      |          |
|       |          |      |          |
|       |          |      |          |
|       |          |      |          |

**INTERFERENCE SEARCHED**

| Class                                | Subclass | Date       | Examiner |
|--------------------------------------|----------|------------|----------|
|                                      |          |            |          |
|                                      |          |            |          |
|                                      |          |            |          |
| Interference search, see<br>printout |          | 11/18/2005 | MN       |

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

|   | DATE       | EXMR |
|---|------------|------|
| EAST (USPUB, USPAT, JPO, EPO,<br>DERWENT, IBM_TDB), See printout  | 4/29/2005  | MN   |
| Limited search (327/147-148, 156-<br>157, 150, 159, 375/373-376, 331/dig.2,<br>1A, 16-17), see printout | 4/29/2005  | MN   |
| Updated   | 9/10/2005  | MN   |
| Updated   | 11/18/2005 | MN   |
|   |            |      |
|   |            |      |
|   |            |      |
|   |            |      |